EO 1-SAA091T09-001 SHEET

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JUN 1 0 1997

Critical Item: 16 Channel Discrete Input Card

Find Number: 78K00477 4 ea.

Hypergol Vapor Detection Sys

Criticality Category: 1S

AREA

CRIT

TOTAL LRU'S

LOA

15

SAA No:

SYSTEM

09IT09-001

System/Area:

LPS/CCMS/FR1/FR2/CR3/CR4

NASA

PMN/

L72-0400-03

Part No:

78K00477/78K02477

Name:

HIM

Mfg/

Part No:

78K00477/78K02477

Drawing/ Sheet No:

MCR7656 VOL. III 4.2 (REV CY)

Function: This HIM Critical Item which can effect support of a critical user system. It accepts 16' DC input signals from user GSE representing unique on/off functions and transmits them to the FEP.

Critical Failure Mode/Failure Mode No: * Failure Mode - Unsolicited operations/09IT09-001.486

* 16 Channel Discrete Input Card failures could cause erroneous data readings or affect normal HIM I/O bus communications resulting resulting in loss of the data path for the critical system being monitored/controlled.

Failure Cause: Electrical/Electronic failure of LRU piece part

Failure Effect:

SYSTEM

FAILURE EFFECT

CRIT

18

Hypergol Vapor Detection System (LOA)

Loss of output signal will fail to provide the console operator with an input that would indicate a leak in the hypergol propellant servicing system. Loss of the capability to detect a leak during hazardous operations could. result in loss of life and/or vehicle. Time to effect: Immediate. Detection method: Software detects loss of HIM function.

16 Channel Discrete Input Card (Continued)

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ACCEPTANCE RATIONALE

Design: The 16 Channel Discrete Input Card was designed per the requirements of the following documents.

- 1. CP09IT0910: General design requirements specification for LPS/CCMS.
- 2. CP09IT0916: Contract end item assembly specifications for HIM for LPS/CCMS.

These specifications support the shuttle design and procurement philosophy procurement of hardware that is not undergoing development, but to procure "off-the-shelf hardware" and to maximum extent possible parts previously qualified through proven design.

Test: Rigorous sets of acceptance tests were performed to verify performance and design requirements of the LPS/CCMS. This process occurred on each end item from "In Process Assembly" phase to "Site Acceptance". Master control procedures (MCPs) 78K-M401 and 78K-M701 were utilized for acceptance testing by MMC. Following this acceptance testing IBM performed integrated testing of each set. Test procedures KSC-LPS-IB-086, Book 3 and KSC-LPS-IB-105, Book 5 were utilized.

Hypergol Vapor Detection Sys

- OMRSD File VI Volume 1 requires a sensor functional test prior to each flow. OMI V3542
 Hypergol Vapor Detection System Operations Support (LPS) provides this end-to-end verification of the system (LPS/HVDS).
- During loading operations, personnel are stationed on the RSS to provide visual monitor.

Inspection: LPS system integrity is continuously monitored by on-line software programs. These programs provide health and status to system operators. OMRSD, File VI requires verification of backup power to be performed every 360 days on the hardware interface module which contains this LRU. OMI C6040 "HIM Preventive Maintenance" satisfies this requirement. Proper HIM operation is verified by each user system as part of the end-to-end verification of their integrated system.

Failure History:

The PRACA Data Base was used for this analyses (timeframe APR. 88 to Sep. 90). There were 13 Problem Reports initiated on 16 Channel Discrete Input Cards that relate to failure modes depicted on this CIL sheet. There is a total population of 1279 16 Channel Discrete Input Cards installed in various CCMS Station Sets. In the basio SAA the timeframe of Jan. 84 to Mar. 88 was used with 107 Problem Reports identified from a total population of 1117 cards installed. Operation use varies from 7 days a week, 24 hours a day to as required.

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16 Channel Discrete Input Card (Continued)

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Operational Use:

• Correcting Action:

Troubleshooting required to isolate and replace failed unit.

• Timeframe:

Varies, troubleshooting required.